

Notice of References Cited	Application/Control No. 10/564,303		Applicant(s)/Patent Under Reexamination UCHIYAMA ET AL.	
	Examiner RENEE DANEGA		Art Unit 3736	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,695,885	02-2004	Schulman et al.	623/25
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NON-PATENT DOCUMENTS

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